



PRODUCT DATA SHEET



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Datasheet

ources Samples

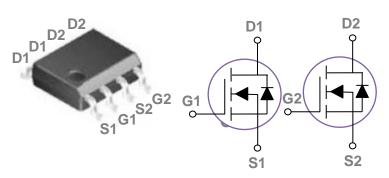
Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.



General Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

Dual	SOP8	Pin	Configuration
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BVDSS	RDSON	ID
30V	32m $Ω$	5.3A

Features

- $30V, 5.3A, RDS(ON) = 32m\Omega @VGS = 10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

Applications

- MB / VGA / Vcore
- POL Applications
- SMPS 2nd SR

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	30	V
V _G s	Gate-Source Voltage	±20	V
1	Drain Current – Continuous (T _A =25°C)	5.3	А
lD	Drain Current – Continuous (T _A =70°C)	4.2	А
I _{DM}	Drain Current – Pulsed ¹	21.2	А
EAS	Single Pulse Avalanche Energy ²	5	mJ
IAS	Single Pulse Avalanched Current ²	10	А
D	Power Dissipation (T _A =25°C)	1.47	W
P _D	Power Dissipation – Derate above 25°C	0.012	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
Тл	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient		85	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted) **Off Characteristics**

Symbol	Parameter Conditions		Min.	Тур.	Max.	Unit
BV _{DSS}	BV _{DSS} Drain-Source Breakdown Voltage V _{GS} =0V , I _D =250uA		30			V
△BV _{DSS} /△T _J	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.018		V/°C
1	Drain-Source Leakage Current	V_{DS} =30V , V_{GS} =0V , T_{J} =25 $^{\circ}$ C			1	uA
I _{DSS}		V _{DS} =24V , V _{GS} =0V , T _J =125°C			10	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V$, $V_{DS}=0V$			±100	nA

On Characteristics

R _{DS(ON)}	Static Drain-Source On-Resistance ³	V _{GS} =10V , I _D =3A		25	32	mΩ
		V _{GS} =4.5V , I _D =2A		43	52	mΩ
V _{GS(th)}	Gate Threshold Voltage	V V I- 2500A	1	1.5	2.2	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	V _{GS} =V _{DS} , I _D =250uA		-3.2		mV/°C
gfs	Forward Transconductance	V_{DS} =10V , I_{D} =3A		2.3		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{3, 4}			3.1	6.4	
Q_{gs}	Gate-Source Charge ^{3,4}	Gate-Source Charge ^{3, 4} V _{DS} =24V , V _{GS} =10V , I _D =2A		0.1	0.5	nC
Q_gd	Gate-Drain Charge ^{3, 4}			1.7	3.4	
$T_{d(on)}$	Turn-On Delay Time ^{3, 4}			2.2	4.5	
Tr	Rise Time ^{3, 4}	V_{DD} =24 V , V_{GS} =10 V , R_{G} =6 Ω		6.9	13.8	
$T_{d(off)}$	Turn-Off Delay Time ^{3, 4}	I _D =1A		15.2	30.4	ns
Tf	Fall Time ^{3, 4}			4.5	9	
Ciss	Input Capacitance			245	490	
Coss	Output Capacitance V _{DS} =25V , V _{GS} =0V , F=1MHz			40	80	pF
Crss	Reverse Transfer Capacitance			78	158	
Rg	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		0.9	1.8	Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V _G =V _D =0V , Force Current			5.3	Α
I _{SM}	Pulsed Source Current ³	VG=VD=0V, Force Current			10.6	Α
V _{SD}	Diode Forward Voltage ³	V _{GS} =0V , I _S =1A , T _J =25°C			1	V

Note :

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2. $V_{DD}=25V$, $V_{GS}=10V$, L=0.1 mH, $I_{AS}=10$ A., $R_{G}=25\Omega$, Starting $T_{J}=25^{\circ}$ C.
- 3. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 4. Essentially independent of operating temperature.



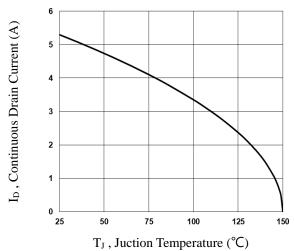


Fig.1 Continuous Drain Current vs. Tc

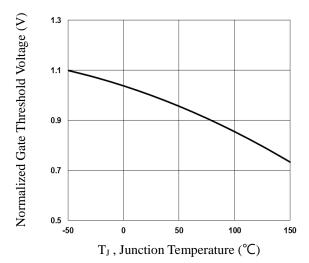


Fig.3 Normalized V_{th} vs. T_J

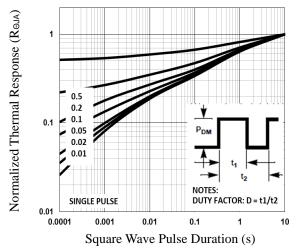


Fig.5 Normalized Transient Response

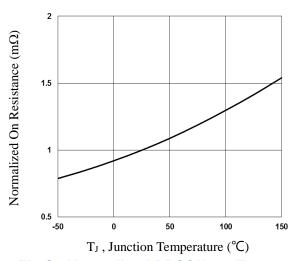


Fig.2 Normalized RDSON vs. T_J

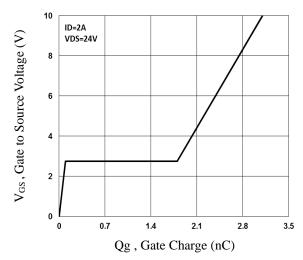


Fig.4 Gate Charge Waveform

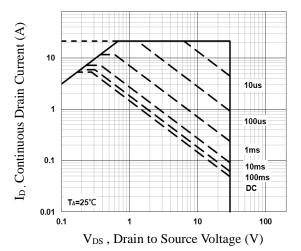
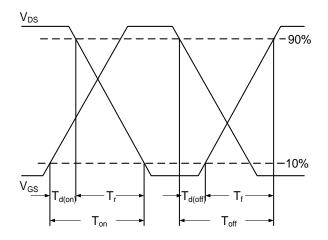


Fig.6 Maximum Safe Operation Area



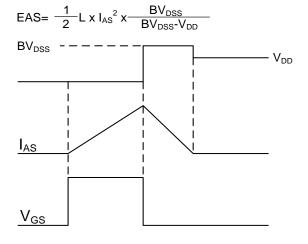
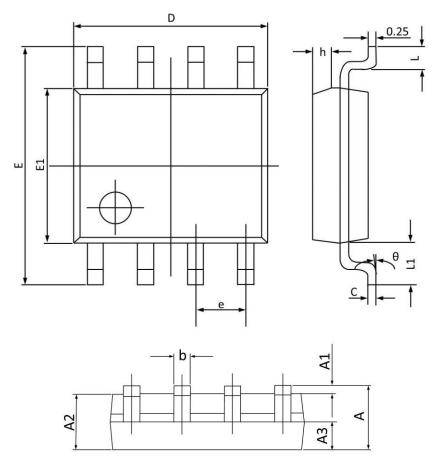


Fig.7 Switching Time Waveform

Fig.8 EAS Waveform



SOP8 PACKAGE INFORMATION



Symbol	Dimensions I	n Millimeters	Dimension	s In Inches
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.068
A1	0.100	0.250	0.004	0.009
A2	1.300	1.500	0.052	0.059
A3	0.600	0.700	0.024	0.027
b	0.390	0.480	0.016	0.018
c	0.210	0.260	0.009	0.010
D	4.700	5.100	0.186	0.200
E	5.800	6.200	0.229	0.244
E1	3.700	4.100	0.146	0.161
e	1.270	(BSC)	0.050	(BSC)
h	0.250	0.500	0.010	0.019
L	0.500	0.800	0.019	0.031
L1	1.050	(BSC)	0.041(BSC)	
θ	0°	8°	0 °	8°



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